

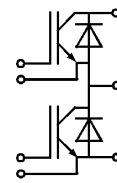
Absolute Maximum Ratings		Values	Units
Symbol	Conditions ¹⁾		
V_{CES}		1700	V
V_{CGR}	$R_{GE} = 20 \text{ k}\Omega$	1700	V
I_C	$T_{case} = 25/80 \text{ }^\circ\text{C}$	150 / 100	A
I_{CM}	$T_{case} = 25/80 \text{ }^\circ\text{C}; t_p = 1 \text{ ms}$	300 / 200	A
V_{GES}		± 20	V
P_{tot}	per IGBT, $T_{case} = 25 \text{ }^\circ\text{C}$	1000	W
$T_j, (T_{stg})$		$-40 \dots +150 (125)$	$^\circ\text{C}$
V_{isol}	AC, 1 min.	4000	V
humidity	DIN 40 040	Class F	
climate	DIN IEC 68 T.1	40/125/56	
Inverse Diode ⁸⁾			
$I_F = -I_C$	$T_{case} = 25/80 \text{ }^\circ\text{C}$	125 / 80	A
$I_{FM} = -I_{CM}$	$T_{case} = 25/80 \text{ }^\circ\text{C}; t_p = 1 \text{ ms}$	300 / 200	A
I_{FSM}	$t_p = 10 \text{ ms}; \sin.; T_j = 150 \text{ }^\circ\text{C}$	1100	A
I^2t	$t_p = 10 \text{ ms}; T_j = 150 \text{ }^\circ\text{C}$	6000	A^2s

Characteristics		min.	typ.	max.	Units
Symbol	Conditions ¹⁾				
$V_{(BR)CES}$	$V_{GE} = 0, I_C = 2 \text{ mA}$	$\geq V_{CES}$	—	—	V
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 8 \text{ mA}$	4,8	5,5	6,2	V
I_{CES}	$V_{GE} = 0 \quad \left\{ \begin{array}{l} T_j = 25 \text{ }^\circ\text{C} \\ T_j = 125 \text{ }^\circ\text{C} \end{array} \right.$	—	—	1,5	mA
	$V_{CE} = V_{CES} \quad \left\{ \begin{array}{l} T_j = 25 \text{ }^\circ\text{C} \\ T_j = 125 \text{ }^\circ\text{C} \end{array} \right.$	—	—	4,5	mA
I_{GES}	$V_{GE} = 20 \text{ V}, V_{CE} = 0 \text{ V}$	—	—	400	nA
V_{CESat}	$I_C = 100 \text{ A} \left\{ \begin{array}{l} V_{GE} = 15 \text{ V}; \\ T_j = 25 (125) \text{ }^\circ\text{C} \end{array} \right.$	—	3,4(4,2)	3,9(5)	V
V_{CESat}	$I_C = 150 \text{ A} \left\{ \begin{array}{l} V_{GE} = 15 \text{ V}; \\ T_j = 25 (125) \text{ }^\circ\text{C} \end{array} \right.$	—	3,8(5,5)	—	V
g_{fs}	$V_{CE} = 20 \text{ V}, I_C = \text{A}$	36	—	—	S
C_{CHC}	per IGBT	—	—	200	pF
C_{ies}	$\left\{ \begin{array}{l} V_{GE} = 0 \\ V_{CE} = 25 \text{ V} \end{array} \right.$	—	16	—	nF
C_{oes}	$\left\{ \begin{array}{l} V_{GE} = 0 \\ V_{CE} = 25 \text{ V} \end{array} \right.$	—	1,3	—	nF
C_{res}	$f = 1 \text{ MHz}$	—	0,5	—	nF
L_{CE}		—	—	20	nH
$t_{d(on)}$	$\left\{ \begin{array}{l} V_{CC} = 1200 \text{ V} \\ V_{GE} = +15 \text{ V} / -15 \text{ V}^{3)} \end{array} \right.$	—	470	—	ns
t_r	$\left\{ \begin{array}{l} V_{CC} = 1200 \text{ V} \\ V_{GE} = +15 \text{ V} / -15 \text{ V}^{3)} \end{array} \right.$	—	90	—	ns
$t_{d(off)}$	$\left\{ \begin{array}{l} I_C = 100 \text{ A, ind. load} \\ R_{Gon} = R_{Goff} = 5 \text{ } \Omega \end{array} \right.$	—	650	—	ns
t_f	$\left\{ \begin{array}{l} I_C = 100 \text{ A, ind. load} \\ R_{Gon} = R_{Goff} = 5 \text{ } \Omega \end{array} \right.$	—	50	—	ns
E_{on}	$T_j = 125 \text{ }^\circ\text{C}$	—	60	—	mWs
E_{off}	$T_j = 125 \text{ }^\circ\text{C}$	—	32	—	mWs
Inverse Diode ⁸⁾					
$V_F = V_{EC}$	$I_F = 100 \text{ A} \left\{ \begin{array}{l} V_{GE} = 0 \text{ V}; \\ T_j = 25 (125) \text{ }^\circ\text{C} \end{array} \right.$	—	2,2(1,9)	2,7(2,4)	V
$V_F = V_{EC}$	$I_F = 150 \text{ A} \left\{ \begin{array}{l} V_{GE} = 0 \text{ V}; \\ T_j = 25 (125) \text{ }^\circ\text{C} \end{array} \right.$	—	2,4(2,2)	—	V
V_{TO}	$T_j = 125 \text{ }^\circ\text{C}$	—	1,2	1,5	V
r_T	$T_j = 125 \text{ }^\circ\text{C}$	—	7	9	m Ω
I_{RR}	$I_F = 100 \text{ A}; T_j = 25 (125) \text{ }^\circ\text{C}^{2)}$	—	50(70)	—	A
Q_{rr}	$I_F = 100 \text{ A}; T_j = 25 (125) \text{ }^\circ\text{C}^{2)}$	—	10(27)	—	μC
Thermal Characteristics					
R_{thjc}	per IGBT	—	—	0,125	$^\circ\text{C/W}$
R_{thjc}	per diode D	—	—	0,40	$^\circ\text{C/W}$
R_{thch}	per module	—	—	0,038	$^\circ\text{C/W}$

SEMITRANS® M IGBT Modules SKM 150 GB 173 D



SEMITRANS 3



GB

Features

- MOS input (voltage controlled)
- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to $6 \cdot I_{cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes⁸⁾
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (13 mm) and creepage distances (20 mm).

Typical Applications

- AC inverter drives on mains 575 - 750 V_{AC}
- DC bus voltage 750 - 1200 V_{DC}
- Public transport (auxiliary syst.)
- Switching (not for linear use)

¹⁾ $T_{case} = 25 \text{ }^\circ\text{C}$, unless otherwise specified

²⁾ $I_F = -I_C$, $V_R = 1200 \text{ V}$,
— $di_F/dt = 1000 \text{ A}/\mu\text{s}$, $V_{GE} = 0 \text{ V}$

³⁾ Use $V_{GEoff} = -5 \dots -15 \text{ V}$

⁸⁾ CAL = Controlled Axial Lifetime Technology.

Cases and mech. data → B6-252

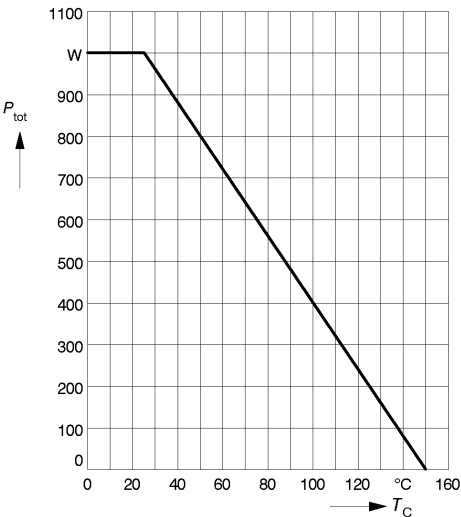


Fig. 1 Rated power dissipation $P_{tot} = f(T_C)$

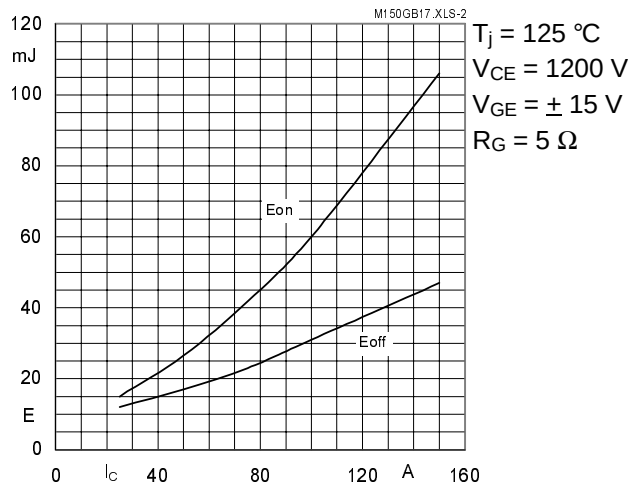


Fig. 2 Turn-on /off energy $= f(I_C)$

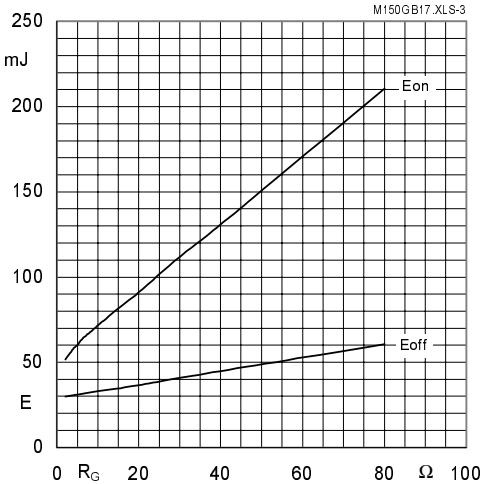


Fig. 3 Turn-on /off energy $= f(R_G)$

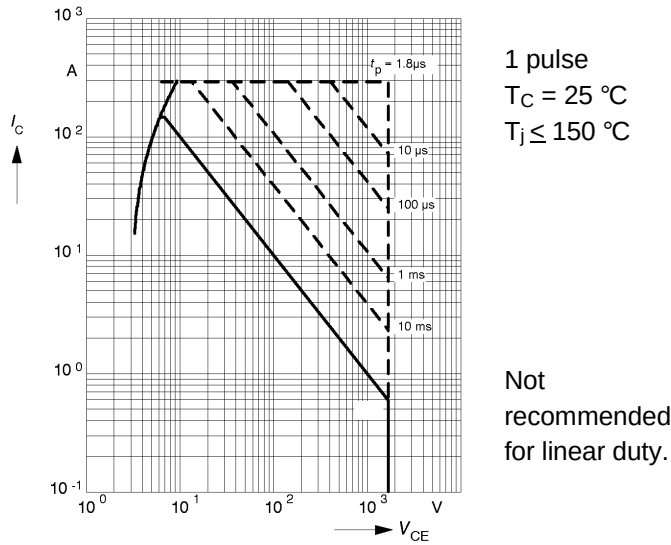


Fig. 4 Maximum safe operating area (SOA) $I_C = f(V_{CE})$

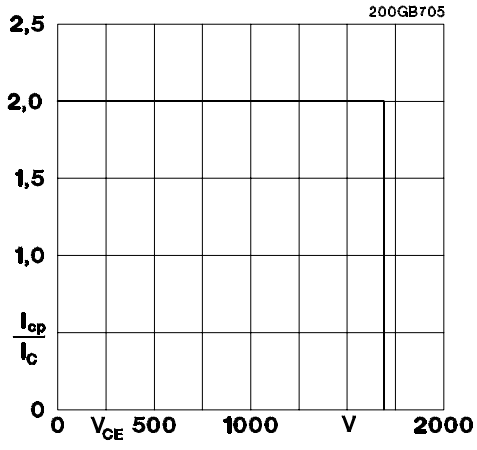


Fig. 5 Turn-off safe operating area (RBSOA)

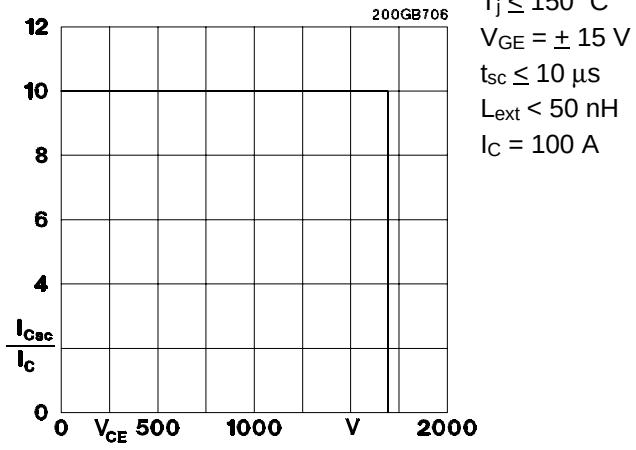


Fig. 6 Safe operating area at short circuit $I_C = f(V_{CE})$

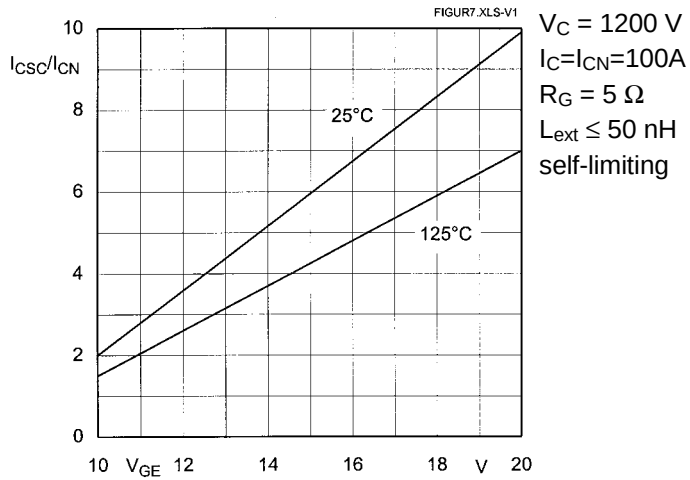


Fig. 7 Short circuit current vs. turn-on gate voltage

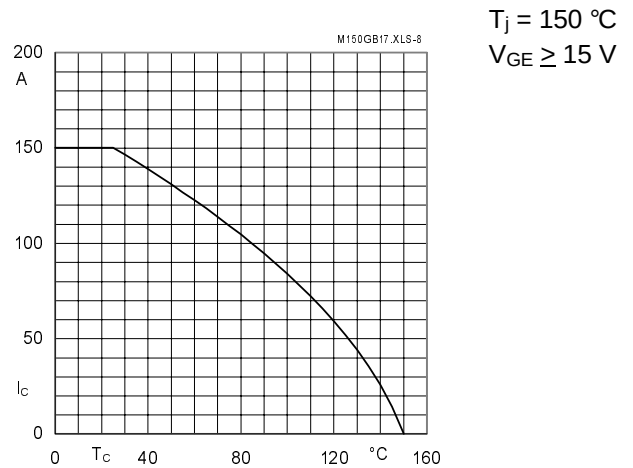


Fig. 8 Rated current vs. temperature $I_C = f(T_C)$

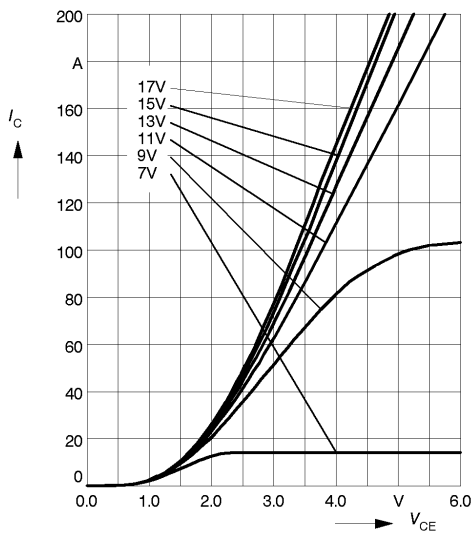


Fig. 9 Typ. output characteristic, $t_p = 80 \mu\text{s}$; $T_j = 25 \text{ °C}$

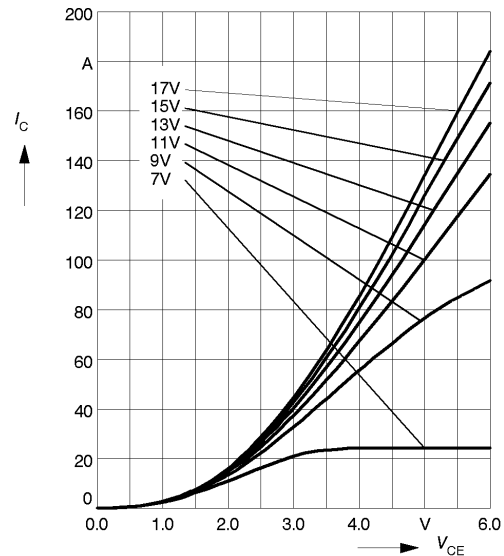


Fig. 10 Typ. output characteristic, $t_p = 80 \mu\text{s}$; $T_j = 125 \text{ °C}$

$$P_{\text{cond}(t)} = V_{\text{CEsat}(t)} \cdot I_C(t)$$

$$V_{\text{CEsat}(t)} = V_{\text{CE(TO)(Tj)}} + r_{\text{CE(Tj)}} \cdot I_C(t)$$

$$V_{\text{CE(TO)(Tj)}} \leq 1,9 + 0,003 (T_j - 25) [\text{V}]$$

$$r_{\text{CE(Tj)}} = 0,017 + 0,00005 (T_j - 25) [\Omega]$$

$$\text{valid for } V_{GE} = +15 \pm 2 \text{ V}; I_C \leq 0,3 I_{C\text{nom}}$$

Fig. 11 Typ. saturation characteristic (IGBT)
 Calculation elements and equations

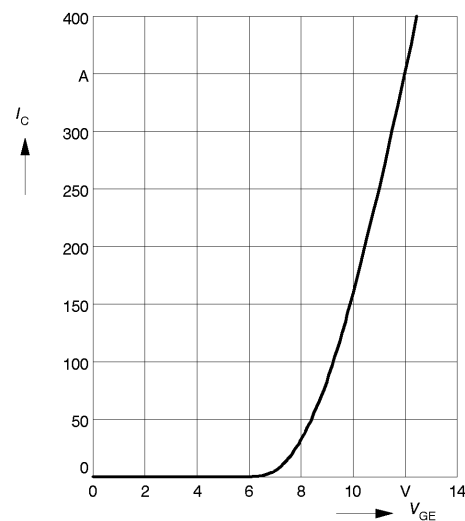


Fig. 12 Typ. transfer characteristic, $t_p = 80 \mu\text{s}$; $V_{CE} = 20 \text{ V}$

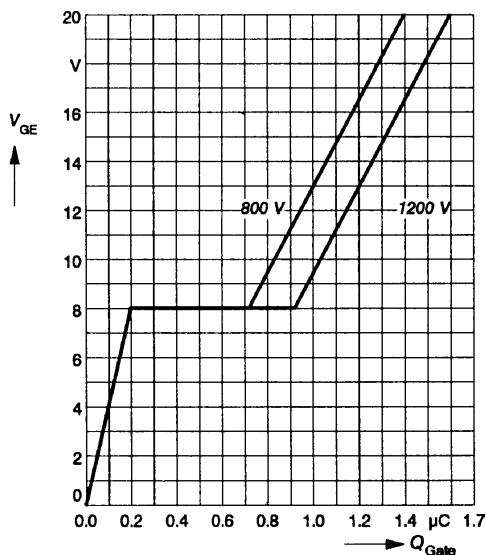


Fig. 13 Typ. gate charge characteristic

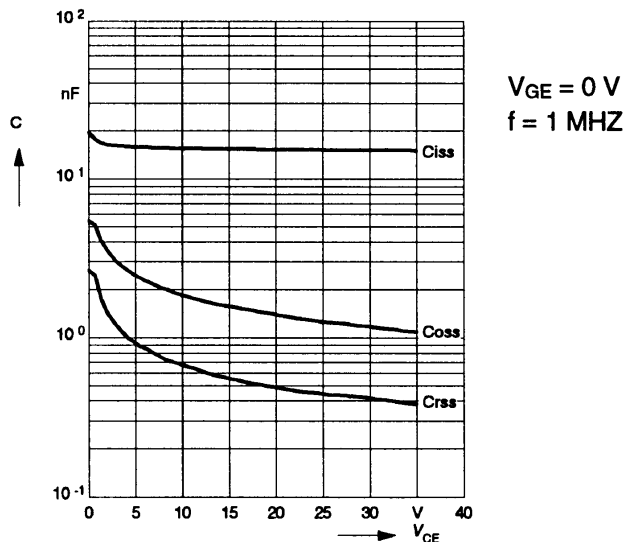


Fig. 14 Typ. capacitances vs. V_{CE}

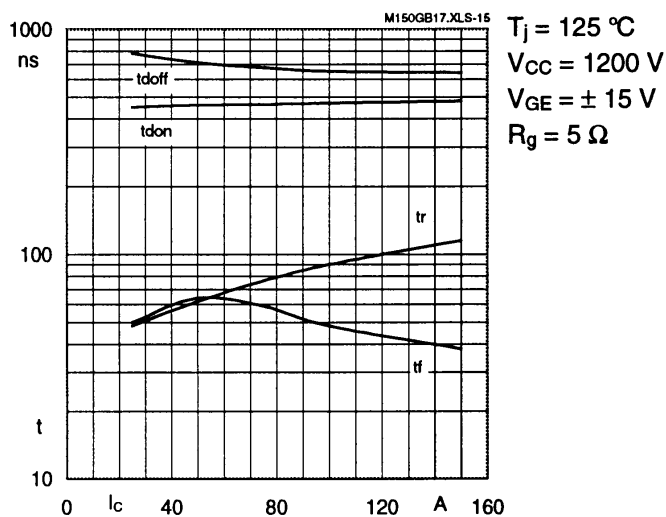


Fig. 15 Typ. switching times vs. I_C

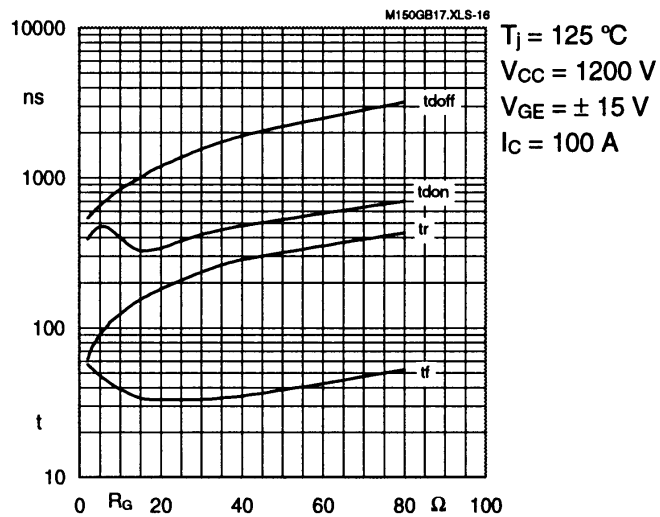


Fig. 16 Typ. switching times vs. R_G

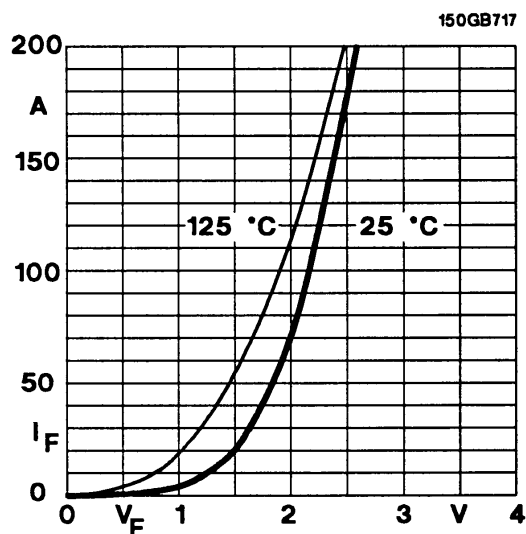


Fig. 17 Typ. CAL diode forward characteristic

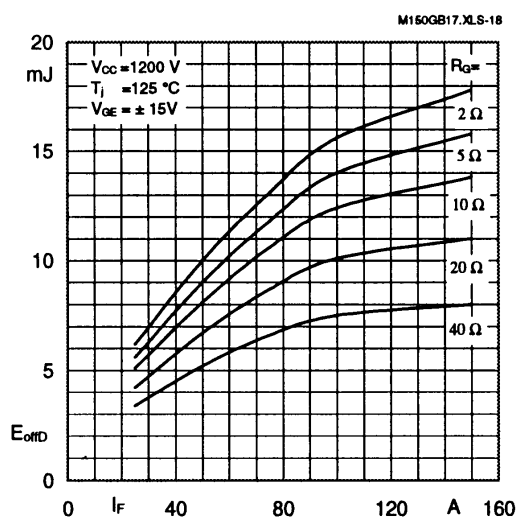


Fig. 18 Typ. Diode turn-off energy dissipation per pulse

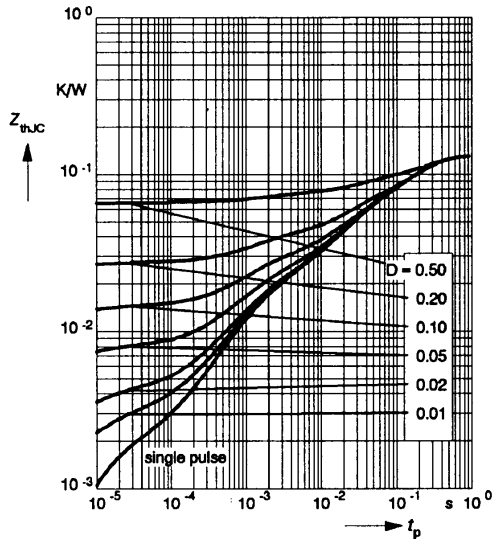


Fig. 19 Transient thermal impedance of IGBT: $Z_{thjc} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

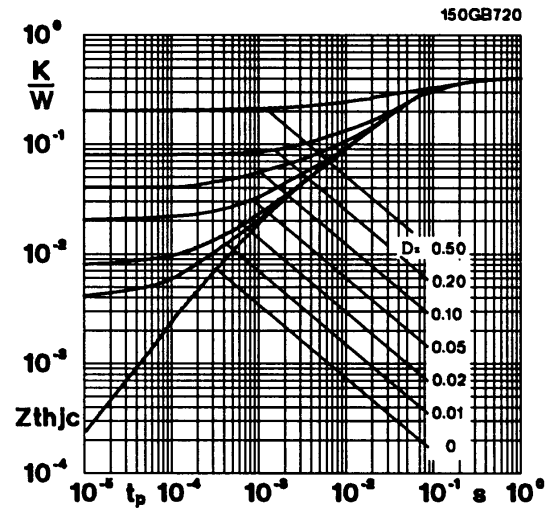


Fig. 20 Transient thermal impedance of inverse diode: $Z_{thjCD} = f(t_p)$

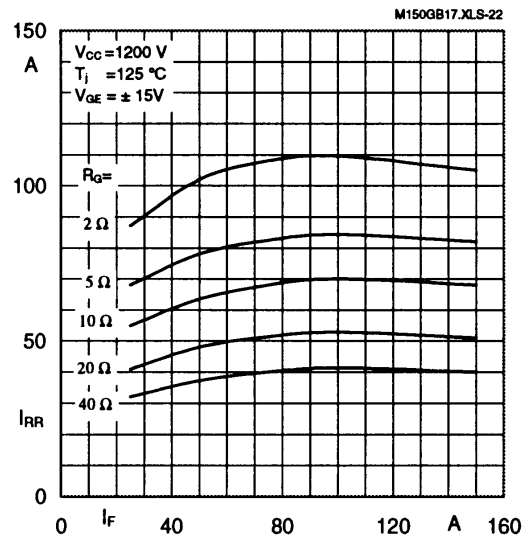


Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$

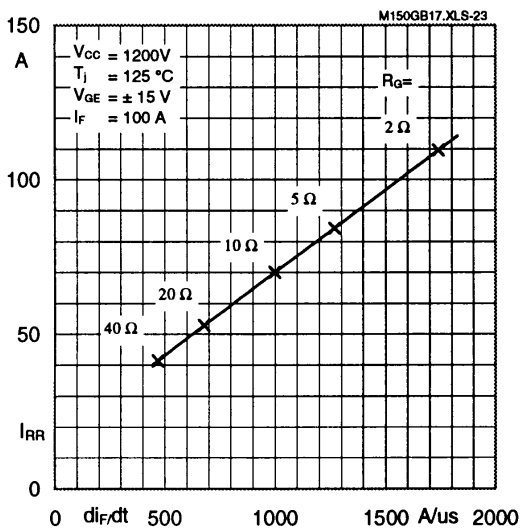


Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di_F/dt)$

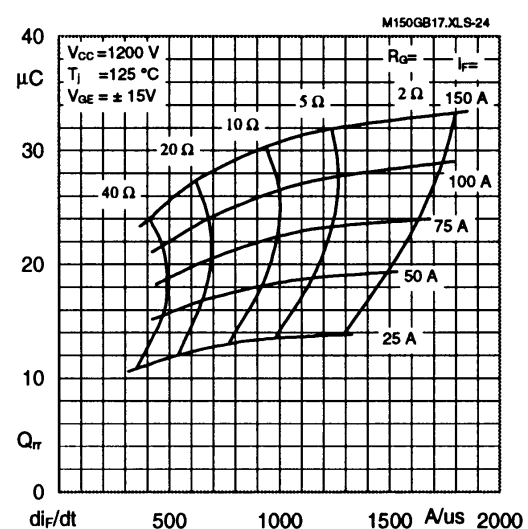


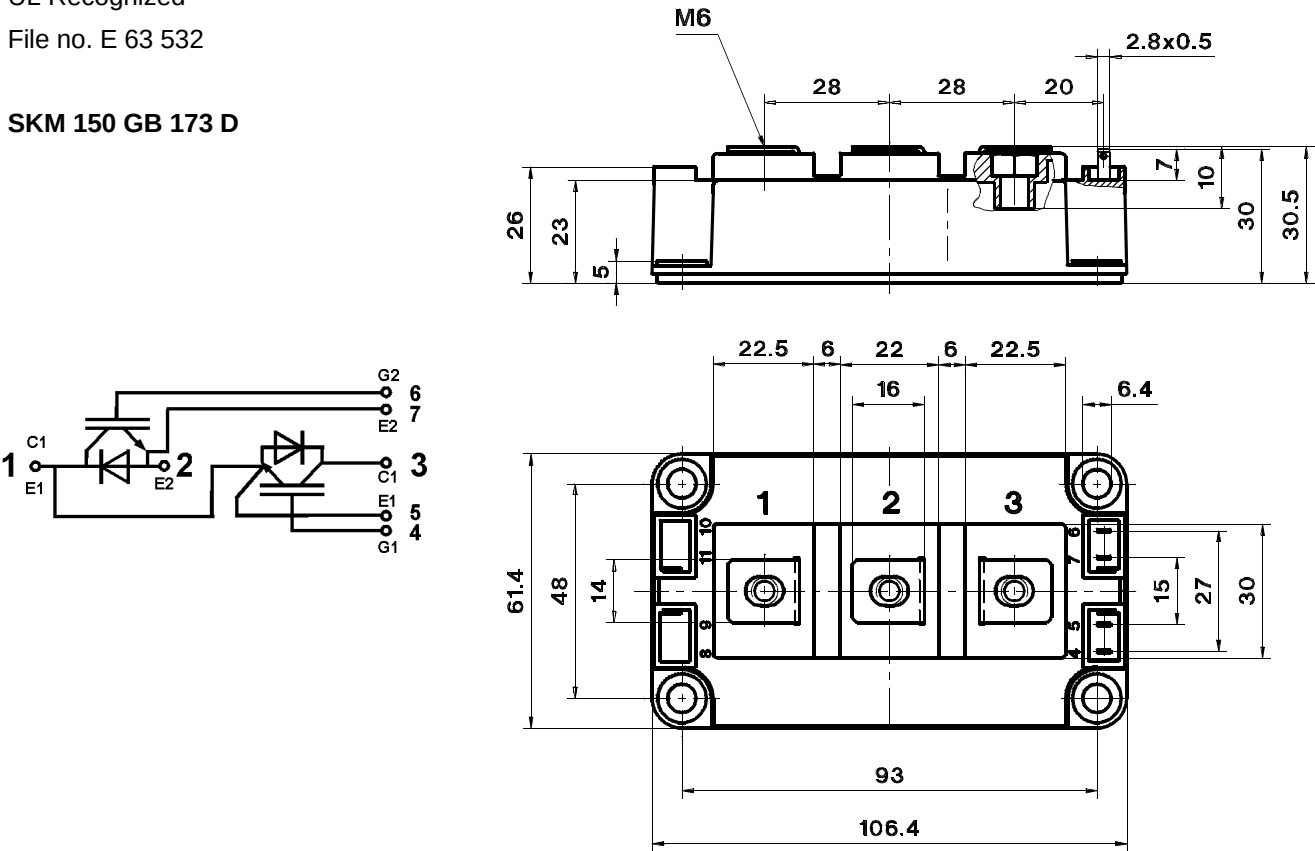
Fig. 24 Typ. CAL diode recovered charge Q_{rr} of inverse diode

SEMITRANS 3

Case D 56
UL Recognized
File no. E 63 532

CASED56

SKM 150 GB 173 D



Dimensions in mm

Case outline and circuit diagrams

Mechanical Data		Values			Units
Symbol	Conditions	min.	typ.	max.	
M ₁	to heatsink, SI Units (M6)	3	—	5	Nm
	to heatsink, US Units	27	—	44	lb.in.
M ₂	for terminals, SI Units (M6)	2,5	—	5	Nm
	for terminals US Units	22	—	44	lb.in.
a		—	—	5x9,81	m/s ²
w		—	—	325	g

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Three devices are supplied in one SEMIBOX B without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 3). Larger packing units of 12 and 20 pieces are used if suitable
Accessories → B 6 - 4.
SEMIBOX → C - 1.